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Øien, D. Wragg, H. Reinsch, S. Svelle, S.

Bordiga, C. Lamberti, K. P. Lillerud

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Detailed Structure Analysis of Atomic Positions and Defects in Zirconium Metal–Organic Frameworks

<u>Sigurd Øien[†]</u>, <u>David Wragg[†]</u>, <u>Helge Reinsch[†]</u>, <u>Stian Svelle[†]</u>, <u>Silvia Bordiga^{†‡}</u>, <u>Carlo</u> <u>Lamberti^{‡§}</u>, and <u>Karl Petter Lillerud^{*†}</u>

[†] Department of Chemistry, University of Oslo, N-0371 Oslo, Norway

* Department of Chemistry, NIS and INSTM Reference Centre, Via Quarello 15, I-10135 Torino, Italy

[§] Southern Federal University, Zorge Street 5, 344090 Rostov-on-Don, Russia

Synopsis

Synchrotron single-crystal X-ray diffraction has been utilized to confirm the complex structure of the Zr-based metal–organic frameworks UiO-66 and UiO-67. The study confirms the presence of missing linkers in UiO-66 and gives an indication of what such a defect may look like. The structures are refined without restraints or solvent correcting algorithms and instead by modeling disordered solvent with dummy atoms.



Zr-based metal–organic frameworks (MOFs) are notable porous materials that recently have gained a lot of attention due to their properties as catalysts, (1, 2) sensor materials, (3) and adsorbents. (4) They consist of discrete $Zr_6O_4(OH)_4$ clusters linked by polycarboxylates, creating porous crystalline networks. The crystal structure of Zr terephthalate MOF UiO-66 was reported in 2008(5) and revised in 2011, (6) solved from powder X-ray diffraction (PXRD), extended X-ray absorption fine structure (EXAFS), and periodic density functional theory (DFT) calculations. This approach was repeated in 2012 for UiO-67.(7)

From thermogravimetric analysis (TGA) and adsorption measurements, it is known that Zr-MOFs are often imperfect in the sense that they have missing linkers, and this is related to stability and other properties. (8-10) The structural models presented so far for these materials, though broadly accurate, do not fully explain some of the properties of the two MOF materials, e.g., unexpected decomposition at low temperatures or in the presence of water. Here we present a model based on single-crystal synchrotron XRD data of exceptionally high quality, showing clear evidence of structural defects caused by missing linkers.

Single crystal X-ray diffraction is able to provide a very accurate picture of electron density, and thus atomic structure, in three dimensions (Figure 1). Although there are a few reported structures for Zr-MOFs, (11-13) these are not of sufficient quality to determine detailed structural features



Figure 1. Partial unit cell of UiO-66 showing a missing linker defect and different positions of μ^3 -O and μ^3 -OH.

Single crystals of UiO-66 and UiO-67 were synthesized by a modification of a previously reported method, using benzoic acid as a monodentate ligand to inhibit crystal seeding. (14) The Erlenmeyer flasks used in the syntheses were submerged in 2.0 M KOH_(aq) overnight prior to use in the reaction, to further inhibit seeding on the glass surface. This resulted in well separated single crystals attached to the inclining surfaces of the synthesis flasks, while the majority of the product formed a membrane of intergrown crystals on the flask bottom (Figure <u>2</u>). A complete description can be found in the <u>Supporting Information</u>.



Figure 2. Optical micrographs with the same degree of magnification of single crystals of UiO-66 (left) and UiO-67 (right).

Single crystal X-ray diffraction experiments were carried out at beamline I911-3 at the MAX2 synchrotron at MaxLab, Lund,(15) working with $\lambda = 0.760$ Å.

The single crystals of UiO-67 were heated to 150 $^{\circ}$ C for 1 h before measurement to remove excess solvent from the pores. The measurements were carried out at 100 K, on two separate crystals of

UiO-66 and two separate crystals from two separate syntheses of UiO-67. The largest UiO-66 single crystals were in the range of 5–10 μ m, while crystals of UiO-67 up to 75 μ m could be found (Figure <u>2</u>).

The crystal structures were refined without imposing restraints. We allowed oxygen atoms with freely refining occupancy factor to occupy the pores, to model disordered electron density, thus avoiding the use of algorithms such as SQUEEZE(16) in the main refinements. The results are summarized in Table <u>1</u>.

Table 1. Structure Refinement Summary of UiO-66 and UiO-67, Both Data Sets Complete to 0.71 Å Resolution, and Space Group Fm3m.

compd	UiO-66	UiO-67
а	20.7465(2) Å	26.8809(3) Å
data/parameters/restraints	739/53/0	1514/55/0 Å
$Zr-\mu^3-O$	2.064(3) Å	2.059(2) Å
Zr-µ ³ -OH	2.254(5) Å	2.256(8) Å
R_1 (all data)	2.44%	2.32%

The refinements show that the samples have hydroxylated clusters, with 0.5 occupancy of both μ^3 -O and μ^3 -OH in all measurements, the positions of which agree with previously reported calculations.(17) The four protons are also required for the charge balance of the cluster. This result is expected since the dehydration of the cluster occurs at 220 °C. The μ_3 -O site is closer to the centroid of the Zr₆ octahedron by ~0.62 Å (Figure <u>3</u>). This is consistent with previous EXAFS data and periodic DFT studies.

The linker occupancy of each structure was allowed to refine freely. In UiO-66, it converged to 73% in both independent refinements and in UiO-67 to close to 100%.



Figure 3. Positions of μ_3 -O and μ_3 -OH in the Zr₆O₄(OH)₄ cluster.

Large irregularities in the electron density were observed around the carboxylate oxygen of UiO-66. The model was made with two separate oxygen atoms to fit this; one with the same occupancy as the linker (called $O_{carboxylate}$) and one with inverse occupancy (called O_{cefect}) (Figure <u>4</u>). It was not possible to further model the chemical structure of the range of molecules, which may occupy the O_{defect} position, and they are assumed to be a mixture of hydroxide, water, and DMF or other coordinating solvents. This finding explains the difference in the intensity of the second shell Zr–Zr

peak in the EXAFS data collected on UiO-66 and UiO-67, in terms of the structural disorder of the $Zr_6O_4(OH)_4$ octahedron induced by missing ligands.(18)



Figure 4. F_{obs} electron density map drawn around a stick model of UiO-66 (top left) and UiO-67 (top right), and a cluster containing both configurations of carboxylate oxygen (bottom).

Although the linker occupancy in UiO-66 is found to be about 73%, this figure may be inaccurate due to correlation between occupancy and three thermal factors, and the partial overlap between the defect and carboxylate position.

Although benzoic acid was used in large amounts in the synthesis of both materials, it is not incorporated into the structure. This would have caused large thermal vibrations of the carbons para to the carboxylic acid group, but no such features are observed in the crystal structures. The relatively large thermal displacement parameters of O_{defect} can be attributed to the defects being multiple species and the proximity to $O_{carboxylate}$.

TGA and PXRD results show slight deviations in linker occupancy from the SC-XRD structures, which indicate minor differences between the single crystals and the bulk sample. The intergrown membrane of crystals in the bulk sample had different growth conditions from those of the single crystals on the flask wall, and there may be other solids present in the sample, such as amorphous Zr terephthalates, oxides, and hydroxides, which cannot easily be separated from the MOF. These results are described in detail in the <u>Supporting Information</u>.

Diffuse scattering was observed on the expected positions of the symmetry-forbidden diffraction peaks $(1 \ 0 \ 0)$, $(1 \ 1 \ 0)$, and $(5 \ 0 \ 0)$, suggesting that there is some long-range order of the defects and/or missing clusters. This has recently been discussed in detail by Cliffe et al.(19)

In conclusion, we have determined the structure of Zr-MOFs UiO-66 and UiO-67 to an unprecedented degree of accuracy, disentangling the μ_3 -O position of the prismatic faces of the Zr₆ octahedron into two distinct μ_3 -O and μ_3 -OH, with occupancy of 0.5 each, and having Zr–O and Zr–OH distances in agreement with those obtained from EXAFS data and periodic DFT studies. The use of benzoic acid in the synthesis prevents the formation of chloride-terminated cluster defects previously observed but does not affect the amount of missing linkers in UiO-66. The missing linkers, along with key differences in the location and thermal motion of the defect oxygen atoms compared to those from linker molecules, explain, on a structural ground, the origin of the different thermal stability of UiO-66 samples prepared with different synthesis methods.(6, 10) This point is of fundamental importance for several possible applications of this class of materials, including their functionalized forms. The results are a significant step toward understanding the stability and behavior of these exciting but complex materials.

Supporting Information

Further details of synthesis, experimental methods, and crystal structure files. This material is available free of charge via the Internet at <u>http://pubs.acs.org</u>.

Accession Codes

The crystal structures are submitted to The Cambridge Crystallographic Data Centre with identifiers CCDC <u>1018045</u> and <u>1018032</u> and can be obtained free of charge from <u>http://www.ccdc.cam.ac.uk/cgi-bin/catreq.cgi</u>.

Author Information

Corresponding Author *E-mail: k.p.lillerud@kjemi.uio.no.

The authors declare no competing financial interest.

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